

MH 248 Hall-effect sensor is a temperature stable, stress-resistant , micro-power switch. Superior high-temperature performance is made possible through a dynamic offset cancellation that utilizes chopper-stabilization. This method reduces the offset voltage normally caused by device over molding, temperature dependencies, and thermal stress.

The MH 248 includes the following on a single silicon chip: voltage regulator, Hall voltage generator, small-signal amplifier, chopper stabilization, Schmitt trigger, and a short circuit protected open-drain output. Advanced CMOS wafer fabrication processing is used to take advantage of low-voltage requirements, component matching, very low input-offset errors, and small component geometries.

This device requires the presence of omni-polar magnetic fields for operation.

The MH 248 is rated for operation between the ambient temperatures -40°C and $+85^{\circ}\text{C}$ for the E temperature range. The four package styles available provide magnetically optimized solutions for most applications. Package types SO is an SOT-23(1.1 mm nominal height),ST is an Tsot-25(0.8 mm nominal height),SU is an USON(0.5 mm nominal height) ,a miniature low-profile surface-mount package, while package UA is a three-lead ultramini SIP for through-hole mounting.

The package type is in a lead (Pb)-free/ Green version was verified by third party Lab.

Features and Benefits

- CMOS Hall IC Technology
- Solid-State Reliability
- Micro power consumption for battery-powered applications
- Omni polar, output switches with absolute value of North or South pole from magnet
- Operation down to 2.5V
- High Sensitivity for direct reed switch replacement applications
- Multi Small Size option
- Custom sensitivity selection is available in optional package.
- Pb Free/Green chip is qualified by third party lab.

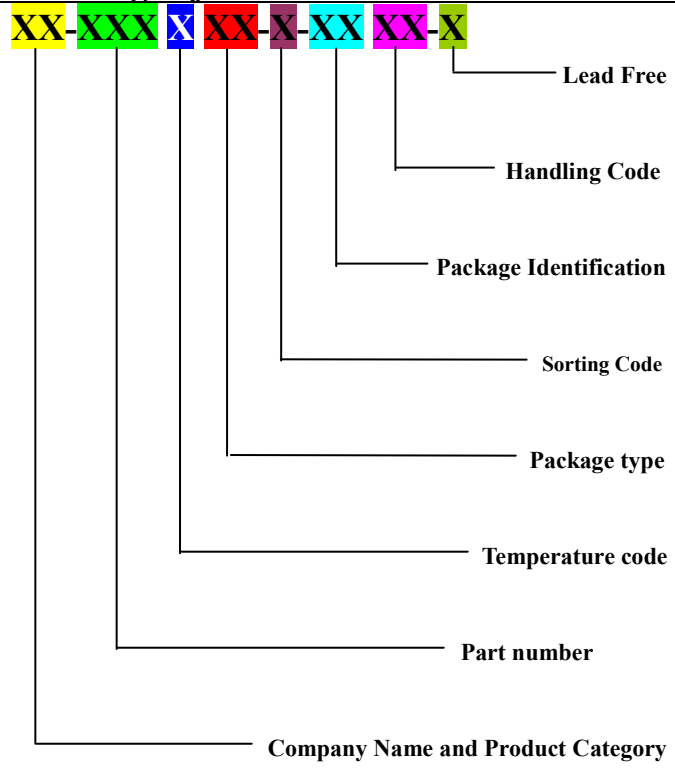
Applications

- Solid state switch
- Handheld Wireless Handset Awake Switch (Flip Cell/PHS Phone/Note Book/Flip Video Set)
- Lid close sensor for battery powered devices
- Magnet proximity sensor for reed switch replacement in low duty cycle applications



High Sensitivity CMOS Micropower Hall Switch

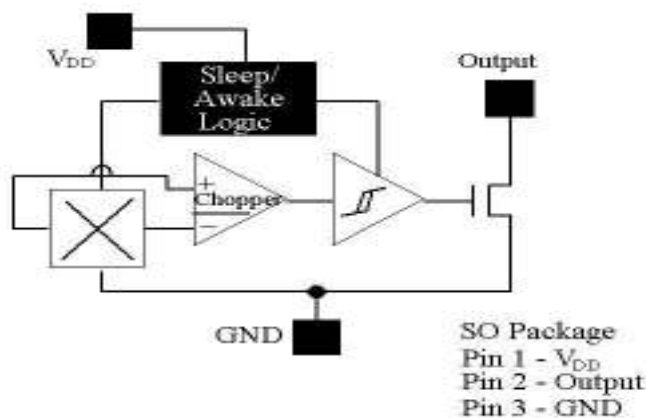
Ordering Information

	Company Name and Product Category MH:MST Hall Effect/MP:MST Power MOSFET Part number 181,182,183,185,248,249,481,482... Temperature range E: 85 Degree C, K: 125 Degree C, L: 150 Degree C Package type UA:TO-92S,SO:SOT-23,ST:Tsol-25,SU:USON Sorting α, β, Blank..... Package Identification Code 01,02,03..... Handling Code BLANK: ESD bag, TR: Tape & Reel Lead Free Code BLANK: Lead Free Device ,G: Green
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Part No.	Temperature Suffix	Package Type	Package Identification
248	E (-40°C to +85°C)	UA (TO-92S)	01
	E (-40°C to +85°C)	SO (SOT-23)	05
	E (-40°C to +85°C)	ST (TSOT-25)	06
	E (-40°C to +85°C)	SU (USON)	07

- Custom sensitivity selection is available

Functional Diagram



Note: Static sensitive device; please observe ESD precautions. Reverse V_{DD} protection is not included. For reverse voltage protection, a 100Ω resistor in series with V_{DD} is recommended.

Absolute Maximum Ratings

Supply Voltage (Operating), V_{DD}	5V
Supply Current (Fault), I_{DD}	5mA
Output Voltage, V_{OUT}	5V
Output Current (Fault), I_{OUT}	5mA
Operating Temperature Range, T_A	-40°C to +85°C
Storage Temperature Range, T_S	-55°C to +150°C

Electrical Specifications

DC operating parameters: $T_A = 25^\circ\text{C}$, $V_{DD}=3V_{DC}$ (unless otherwise specified).

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Supply Voltage	V_{DD}	Operating	2.5		3.5	V
Supply Current	I_{DD}	Average		8.0		μA
Awake supply Current		Awake On		1.5		mA
Output Current	I_{OUT}				1.0	mA
Saturation Voltage	V_{SAT}	$I_{OUT} = 1\text{mA}$			0.4	V
Awake mode time	T_{aw}	Operating		175.0		μS
Sleep mode time	T_{sl}	Operating			70.0	mS

MH248ESO/UA/ST/SU Magnetic Specifications

DC operating parameters: $T_A = 25^\circ\text{C}$, $V_{DD}=3V_{DC}$ (unless otherwise specified).

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Operating Point	B_{OPS}	South pole to branded side, $B > BOP$, Vout On	0.6		6.0	mT
	B_{OPN}	North pole to branded side, $B > BOP$, Vout On	-6.0		-0.6	mT
Release Point	B_{RPS}	South pole to branded side, $B < BRP$, Vout Off	0.5		5.9	mT
	B_{RPN}	North pole to branded side, $B < BRP$, Vout Off	-5.9		-0.5	mT
Hysteresis	B_{HYS}	$ BOPx - BRPx $		0.7		mT

Note: 1 mT = 10 Gauss.

MH248ESO/UA/ST/SU- α Magnetic Specifications

DC operating parameters: $T_A = 25^\circ\text{C}$, $V_{DD}=3V_{DC}$ (unless otherwise specified).

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Operating Point	B_{OPS}	North pole to branded side, $B > BOP$, Vout On	2.1		4.0	mT
	B_{OPN}		-6.0		-0.6	mT
Release Point	B_{RPS}	North pole to branded side, $B < BRP$, Vout Off	2.0		3.9	mT
	B_{RPN}		-5.9		-0.5	mT
Hysteresis	B_{HYS}	$ BOPx - BRPx $		0.7		mT

Note: 1 mT = 10 Gauss.

MH248ESO/UA/ST/SU-β Magnetic Specifications

DC operating parameters: $T_A = 25^\circ\text{C}$, $V_{DD} = 3V_{DC}$ (unless otherwise specified).

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Operating Point	B _{OPS}	North pole to branded side, $B > BOP$, Vout On	3.1		6.0	mT
	B _{OPN}		-6.0		-0.6	mT
Release Point	B _{RPS}	North pole to branded side, $B < BRP$, Vout Off	3.0		5.9	mT
	B _{RPN}		-5.9		-0.5	mT
Hysteresis	B _{HYS}	$ BOPx - BRPx $		0.7		mT

Note: 1 mT = 10 Gauss.

MH248ESO/UA/ST/SU-γ Magnetic Specifications

DC operating parameters: $T_A = 25^\circ\text{C}$, $V_{DD} = 3V_{DC}$ (unless otherwise specified).

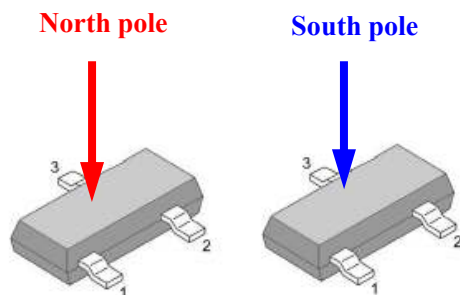
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Operating Point	B _{OPS}	North pole to branded side, $B > BOP$, Vout On	0.6		3.5	mT
	B _{OPN}		-6.0		-0.6	mT
Release Point	B _{RPS}	North pole to branded side, $B < BRP$, Vout Off	0.5		3.4	mT
	B _{RPN}		-5.9		-0.5	mT
Hysteresis	B _{HYS}	$ BOPx - BRPx $		0.7		mT

Note: 1 mT = 10 Gauss.

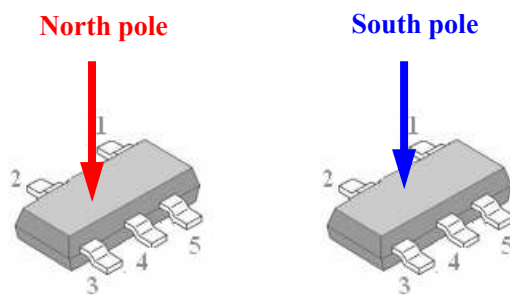
MH248ESO/UA/ST/SU Output Behavior versus Magnetic Polar

DC Operating Parameters $T_a = -40$ to 85°C , $V_{dd} = 2.5$ to $5V$

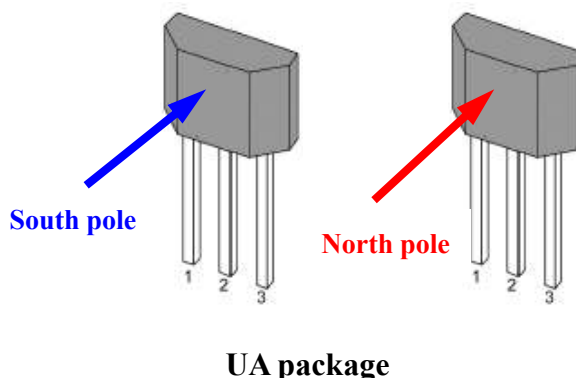
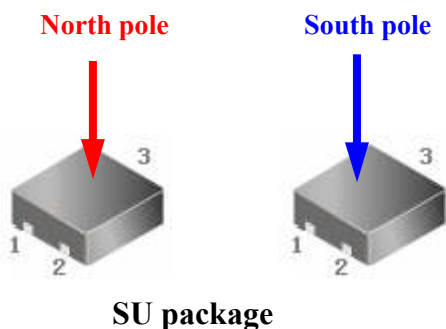
Parameter	Test condition	OUT(SO/ST)	Test condition	OUT(UA/SU)
South pole	$B > Bop[(-60)-(-6)]$	low	$B > Bop(6-60)$	low
Null or weak magnetic field	$B = 0$ or $B < BRP$	high	$B = 0$ or $B < BRP$	high
North pole	$B > Bop(6-60)$	low	$B > Bop[(-60)-(-6)]$	low



SO package



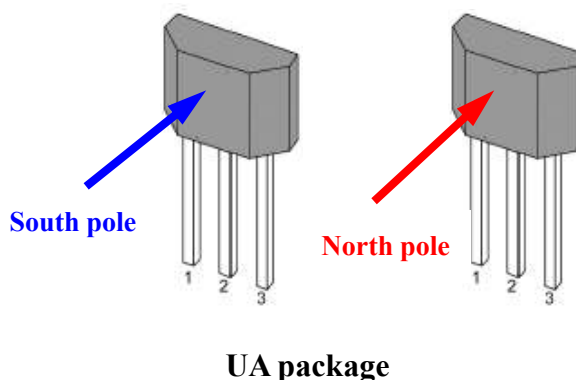
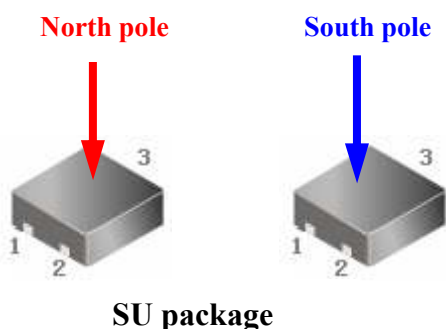
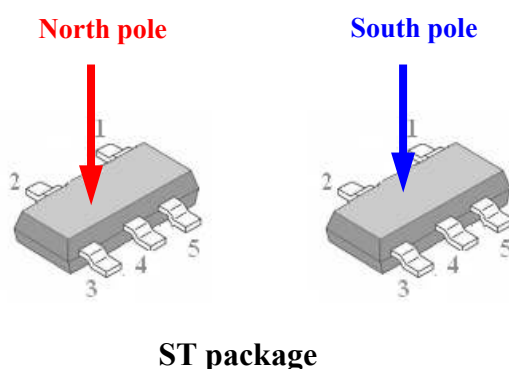
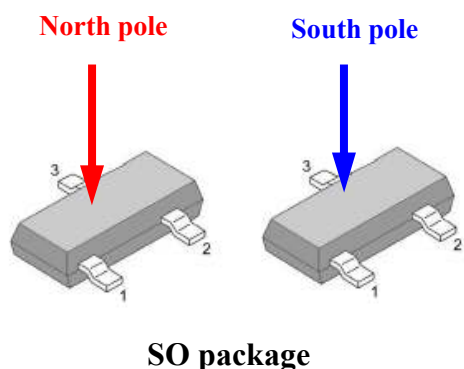
ST package



MH248ESO/UA/ST/SU- α Output Behavior versus Magnetic Polar

DC Operating Parameters $T_a = -40$ to 85°C , $V_{dd} = 2.5$ to 5V

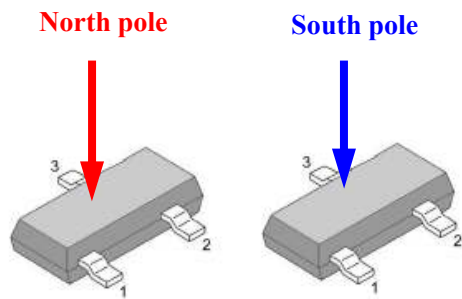
Parameter	Test condition	OUT(SO/ST)	Test condition	OUT(UA/SU)
South pole	$B > B_{op}[(-60)-(-6)]$	low	$B > B_{op}(21-40)$	low
Null or weak magnetic field	$B=0$ or $B < BRP$	high	$B=0$ or $B < BRP$	high
North pole	$B > B_{op}(21-40)$	low	$B > B_{op}[(-60)-(-6)]$	low



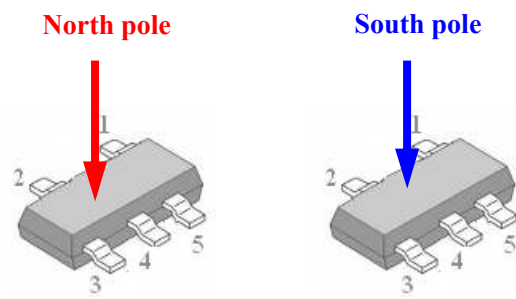
MH248ESO/UA/ST/SU- β Output Behavior versus Magnetic Polar

DC Operating Parameters $T_a = -40$ to 85°C , $V_{dd} = 2.5$ to 5V

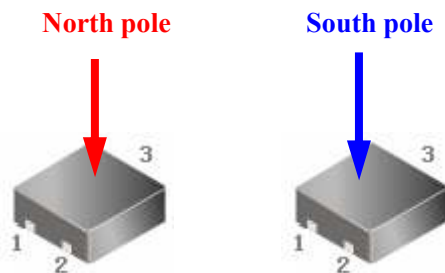
Parameter	Test condition	OUT(SO/ST)	Test condition	OUT(UA/SU)
South pole	$B > B_{op}[(-60)-(-6)]$	low	$B > B_{op}(31-60)$	low
Null or weak magnetic field	$B=0$ or $B < BRP$	high	$B=0$ or $B < BRP$	high
North pole	$B > B_{op}(30-60)$	low	$B > B_{op}[(-60)-(-6)]$	low



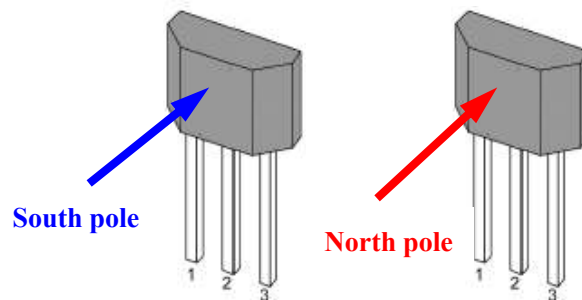
SO package



ST package



SU package

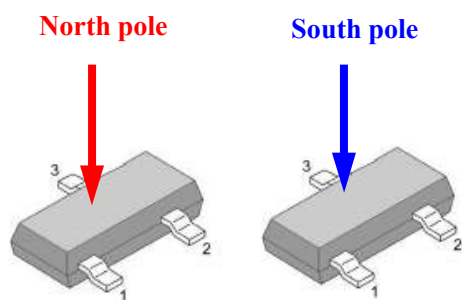


UA package

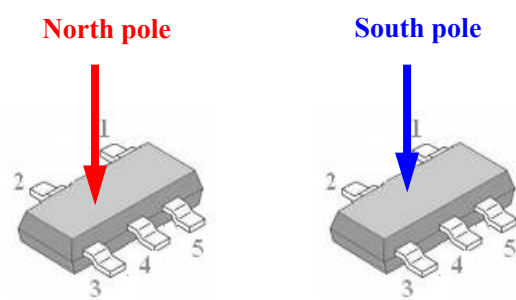
MH248ESO/UA/ST/SU-γ Output Behavior versus Magnetic Polar

DC Operating Parameters $T_a = -40$ to 85°C , $V_{dd} = 2.5$ to 5V

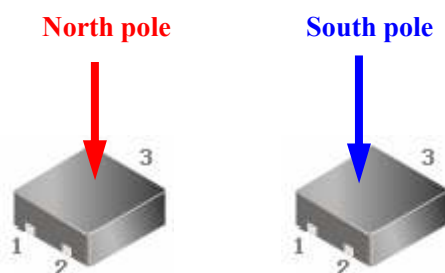
Parameter	Test condition	OUT(SO/ST)	Test condition	OUT(UA/SU)
South pole	$B > B_{op}[(-60)-(-6)]$	low	$B > B_{op}(6-35)$	low
Null or weak magnetic field	$B = 0$ or $B < BRP$	high	$B = 0$ or $B < BRP$	high
North pole	$B > B_{op}(6-35)$	low	$B > B_{op}[(-60)-(-6)]$	low



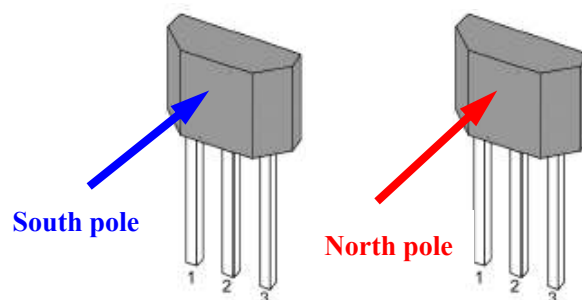
SO package



ST package

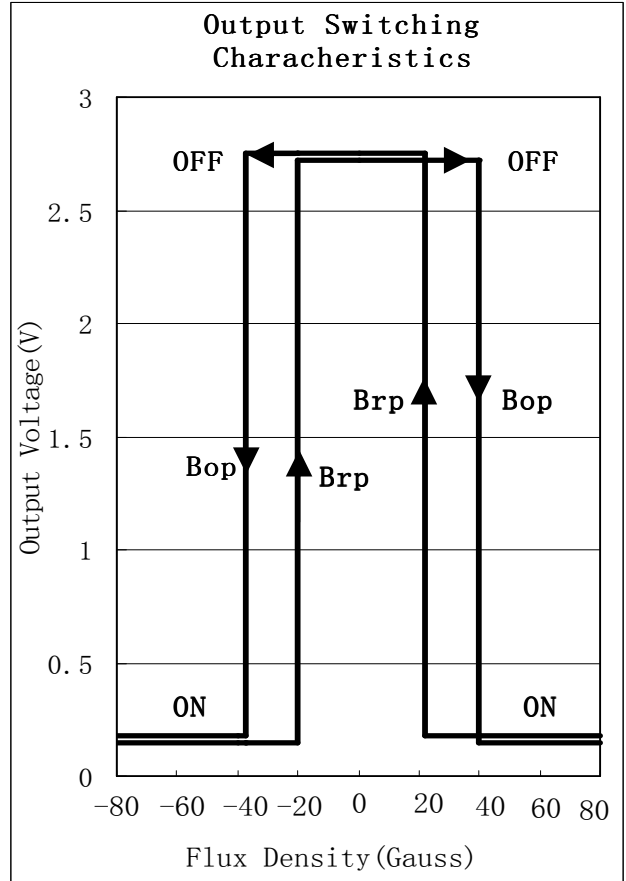
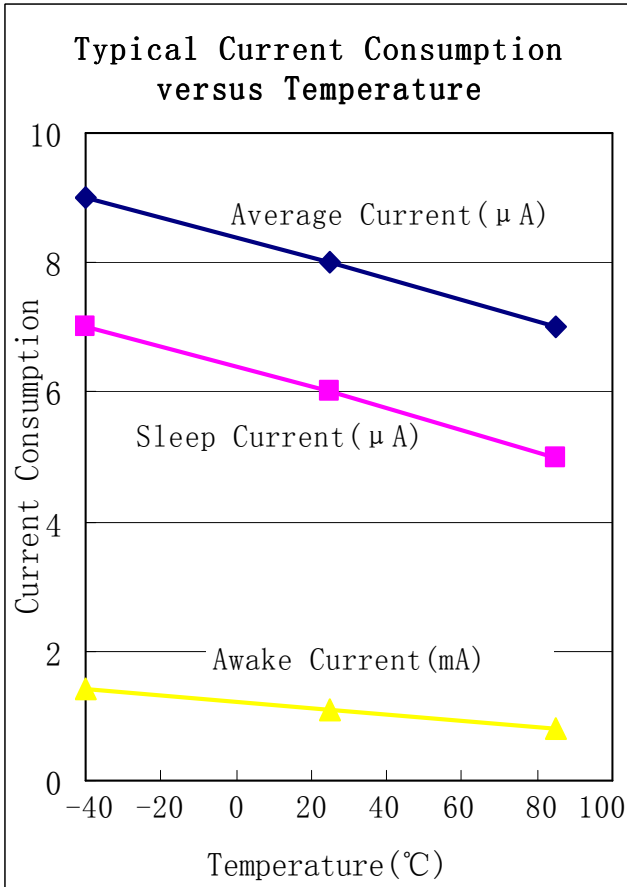
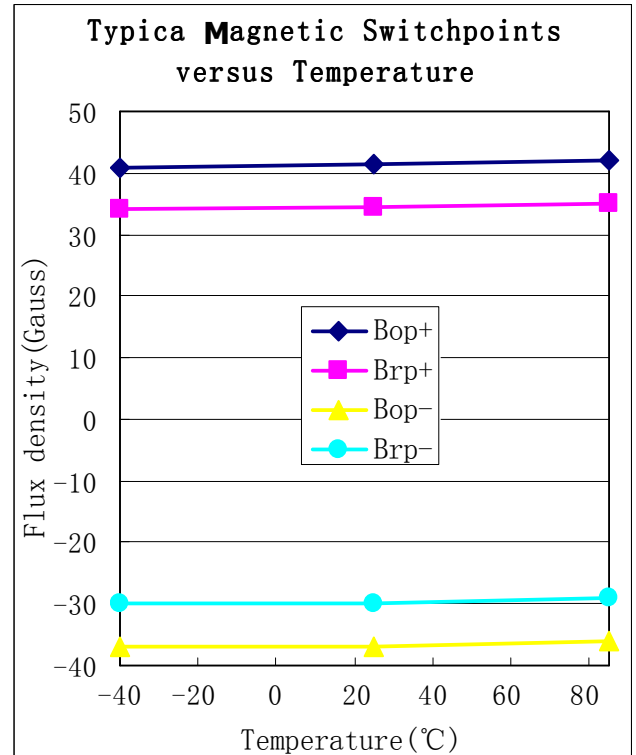
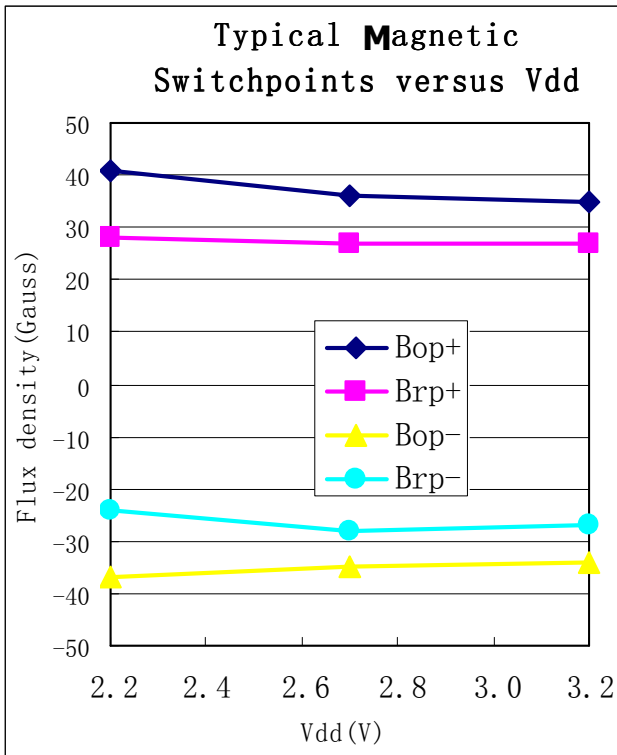


SU package



UA package

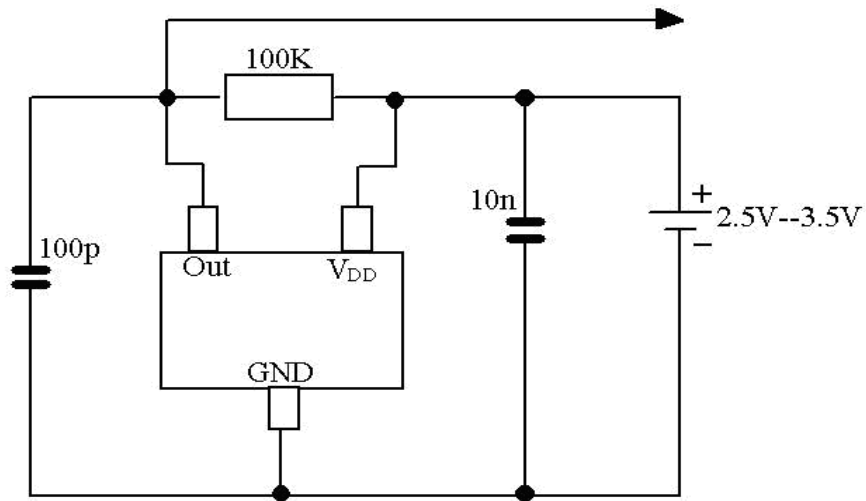
Performance Graphs



Installation Comments

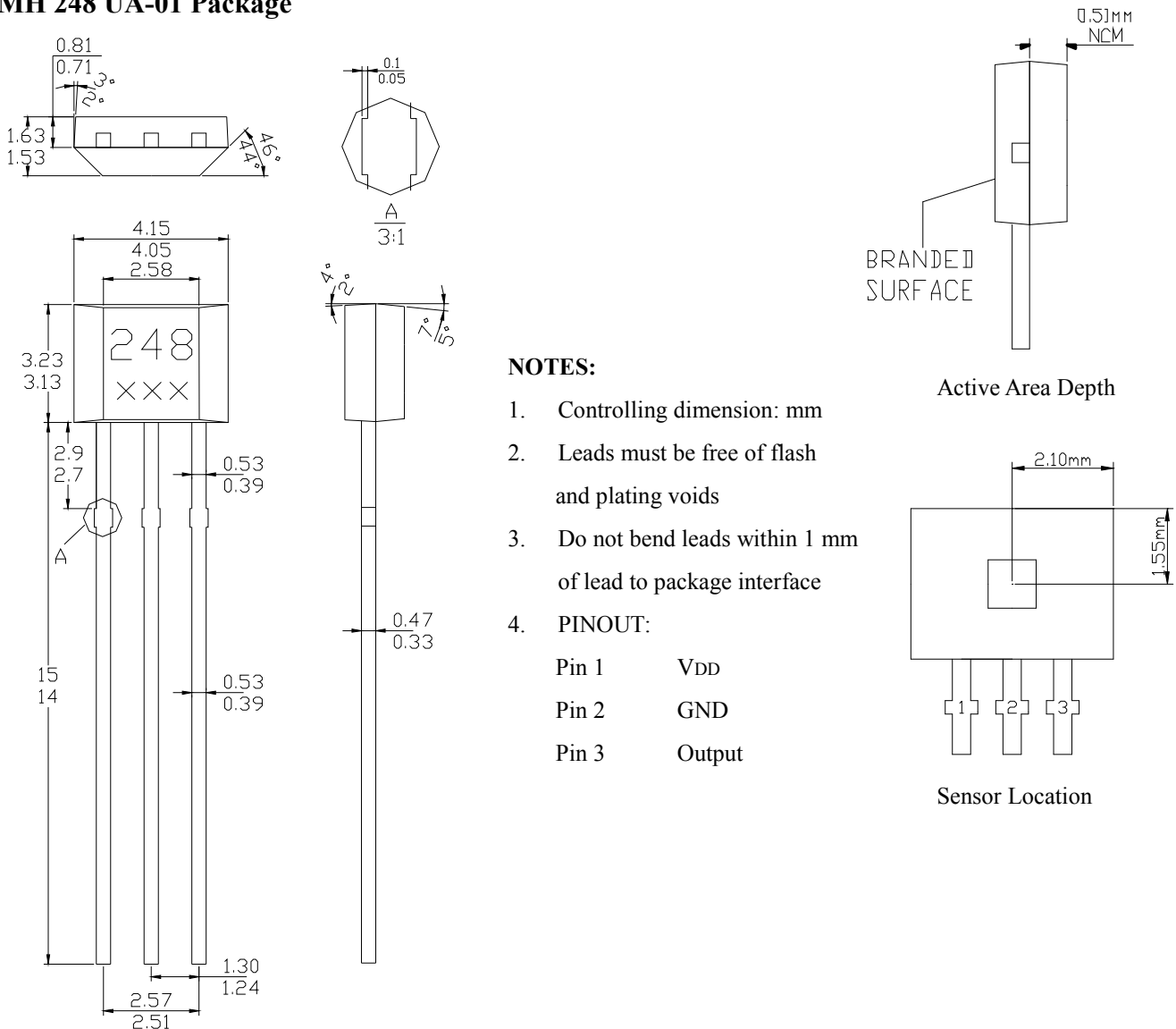
Consider temperature coefficients of Hall IC and magnetic, as well as air gap and life time variations. Observe temperature limits during wave soldering.

Typical Application

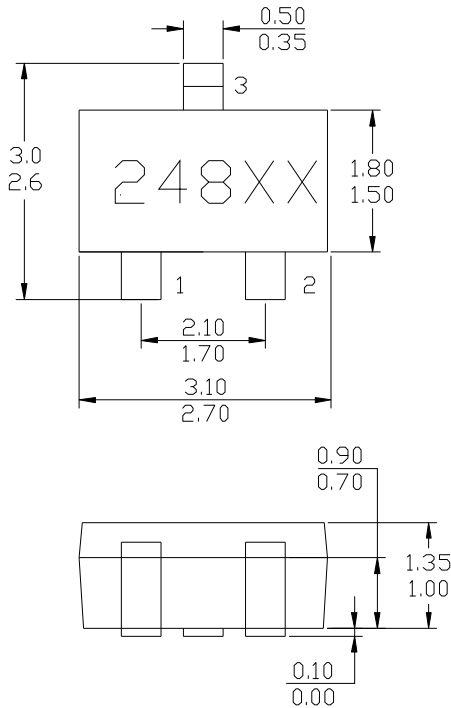


Sensor Location, package dimension and marking

MH 248 UA-01 Package



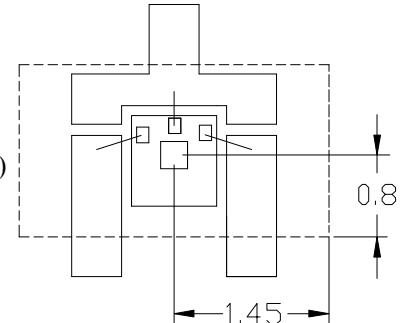
**MH 248 SO-05 Package
(Top View)**



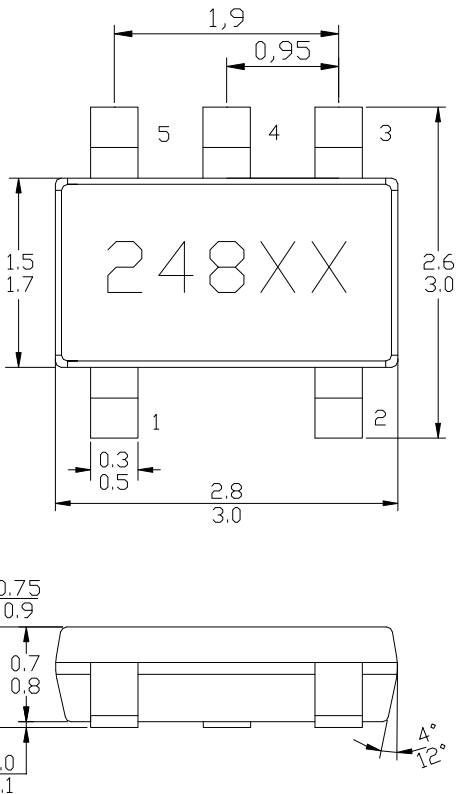
NOTES:

- PINOUT (See Top View at left):
Pin 1 VDD
Pin 2 Output
Pin 3 GND
- Controlling dimension: mm;
- Lead thickness after solder plating will be 0.254mm maximum.

**SOT-23 Hall Plate / Chip Location
(Bottom view)**



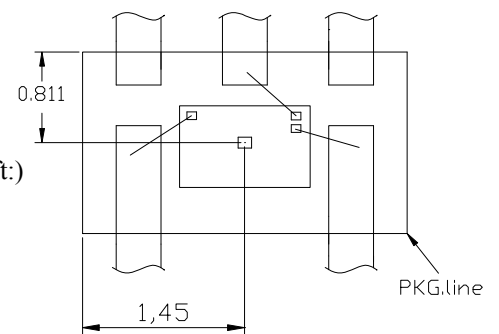
**MH 248 ST-06 Package
TSOT-25 Package Dimension
(Top View)**



NOTES:

- PINOUT (See Top View at left):
Pin 1 VDD
Pin 2 Output
Pin 3 NC
Pin 4 GND
Pin 5 NC
- Controlling dimension: mm;
- Chip rubbing will be 10mil maximum;
- Chip must be in PKG. center.

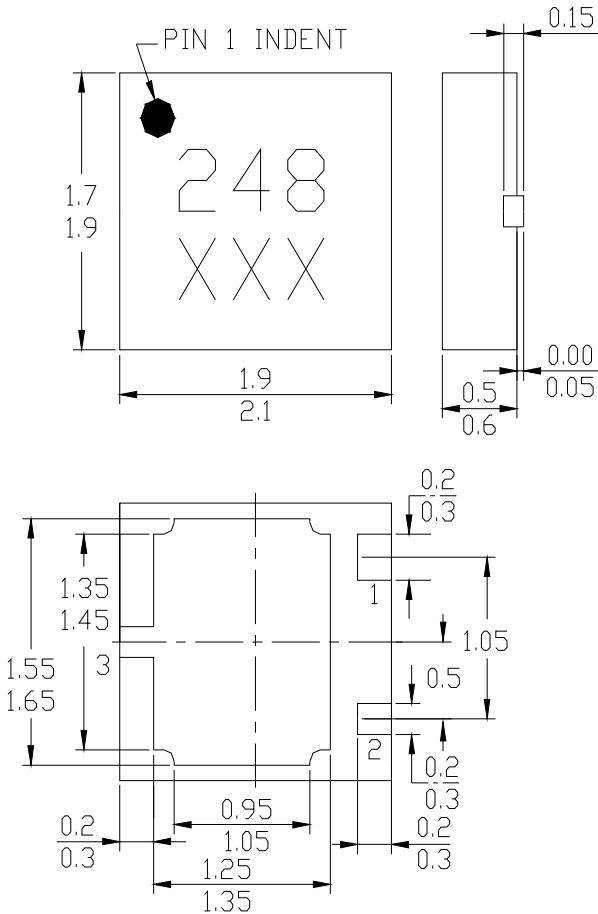
**TSOT-25 Hall Plate / Chip Location
(Bottom view)**



MH 248 SU-07 Package

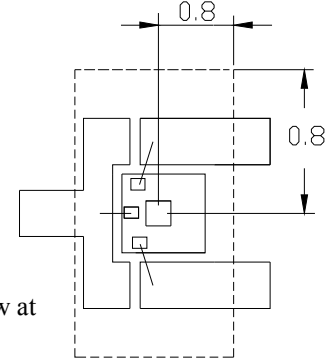
USON Package Dimension

(Top View)



USON Hall Plate / Chip Location

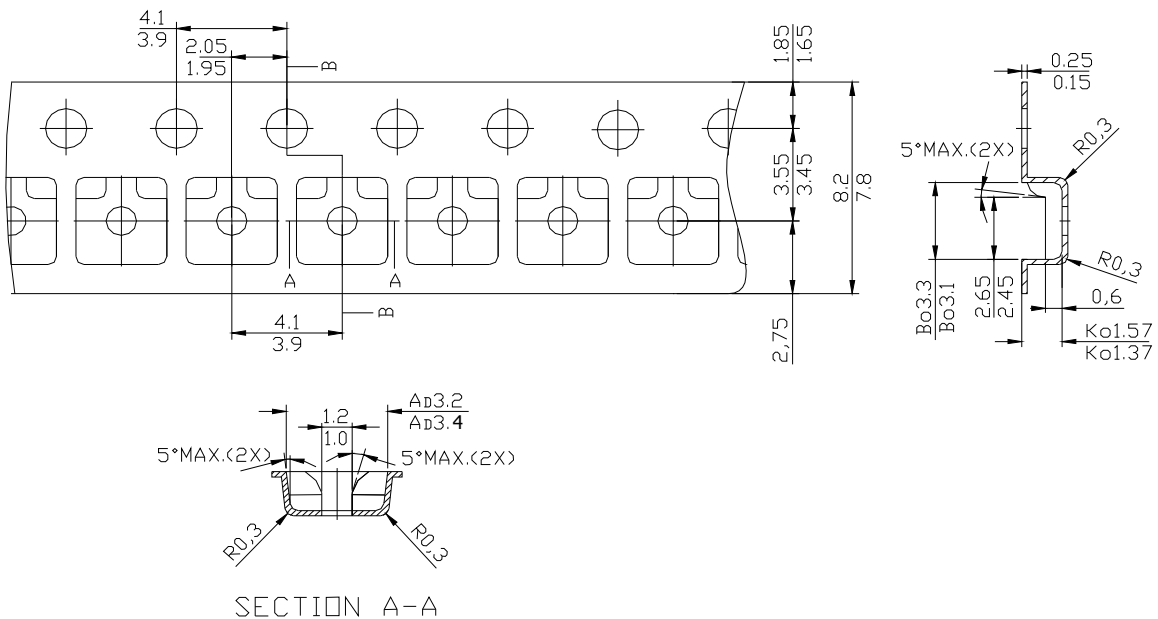
(Bottom view)

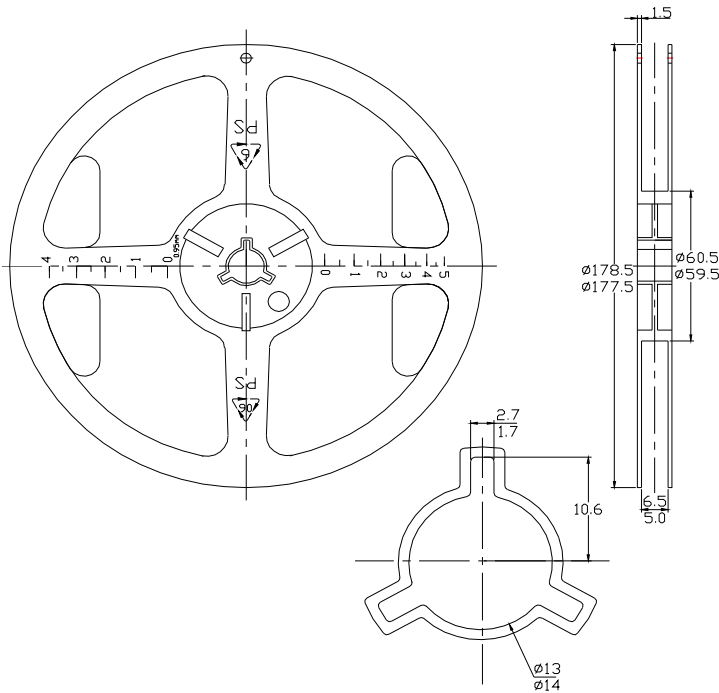


NOTES:

1. PINOUT (See Top View at left:
Pin 1 VDD
Pin 2 Output
Pin 3 GND
2. Controlling dimension: mm;
3. Chip rubbing will be 10mil maximum;
4. Chip must be in PKG. center.

Sot 23 package Tape On Reel Dimension

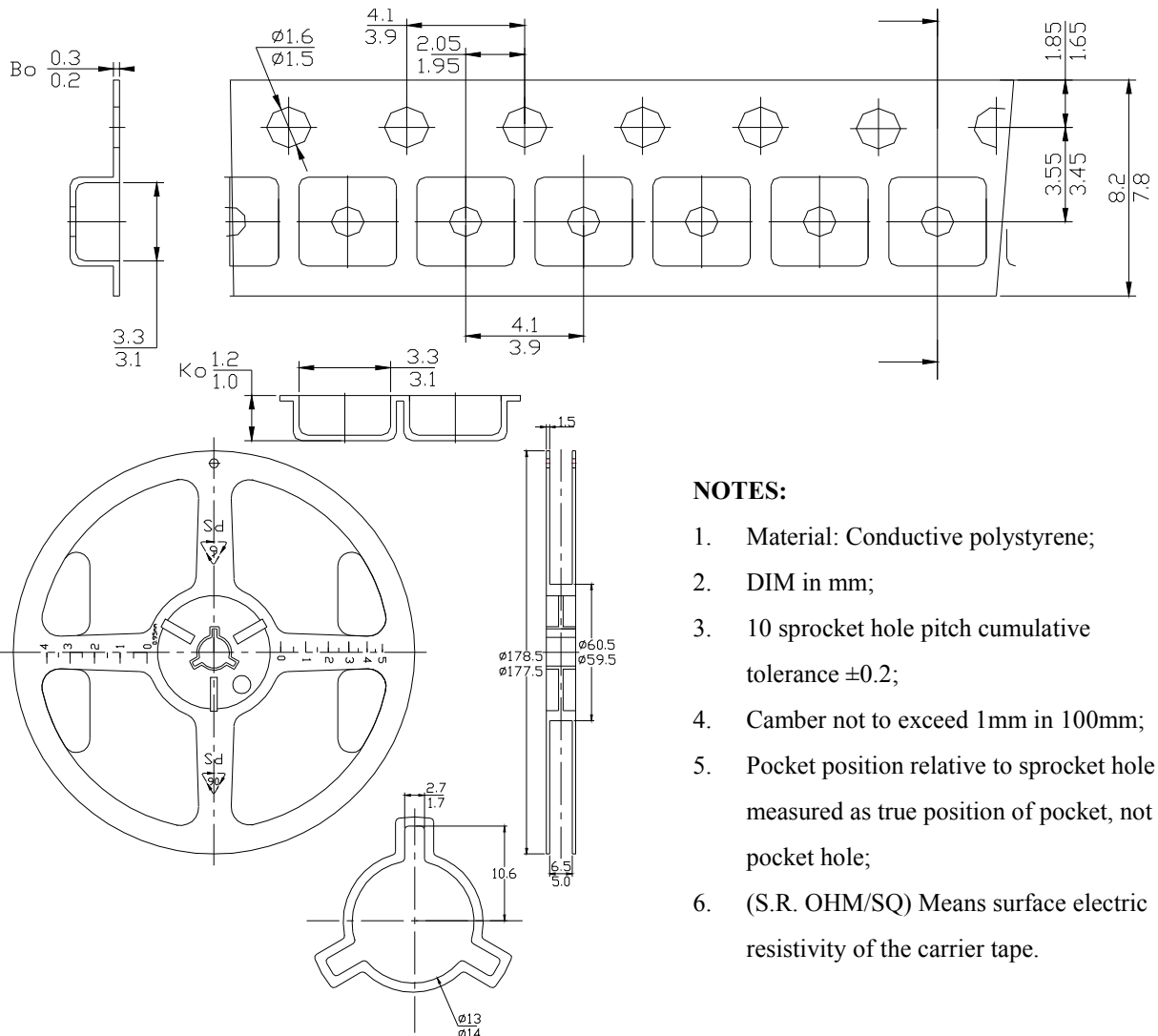




NOTES:

1. Material: Conductive polystyrene;
2. DIM in mm;
3. 10 sprocket hole pitch cumulative tolerance ± 0.2 ;
4. Camber not to exceed 1mm in 100mm;
5. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole;
6. (S.R. OHM/SQ) Means surface

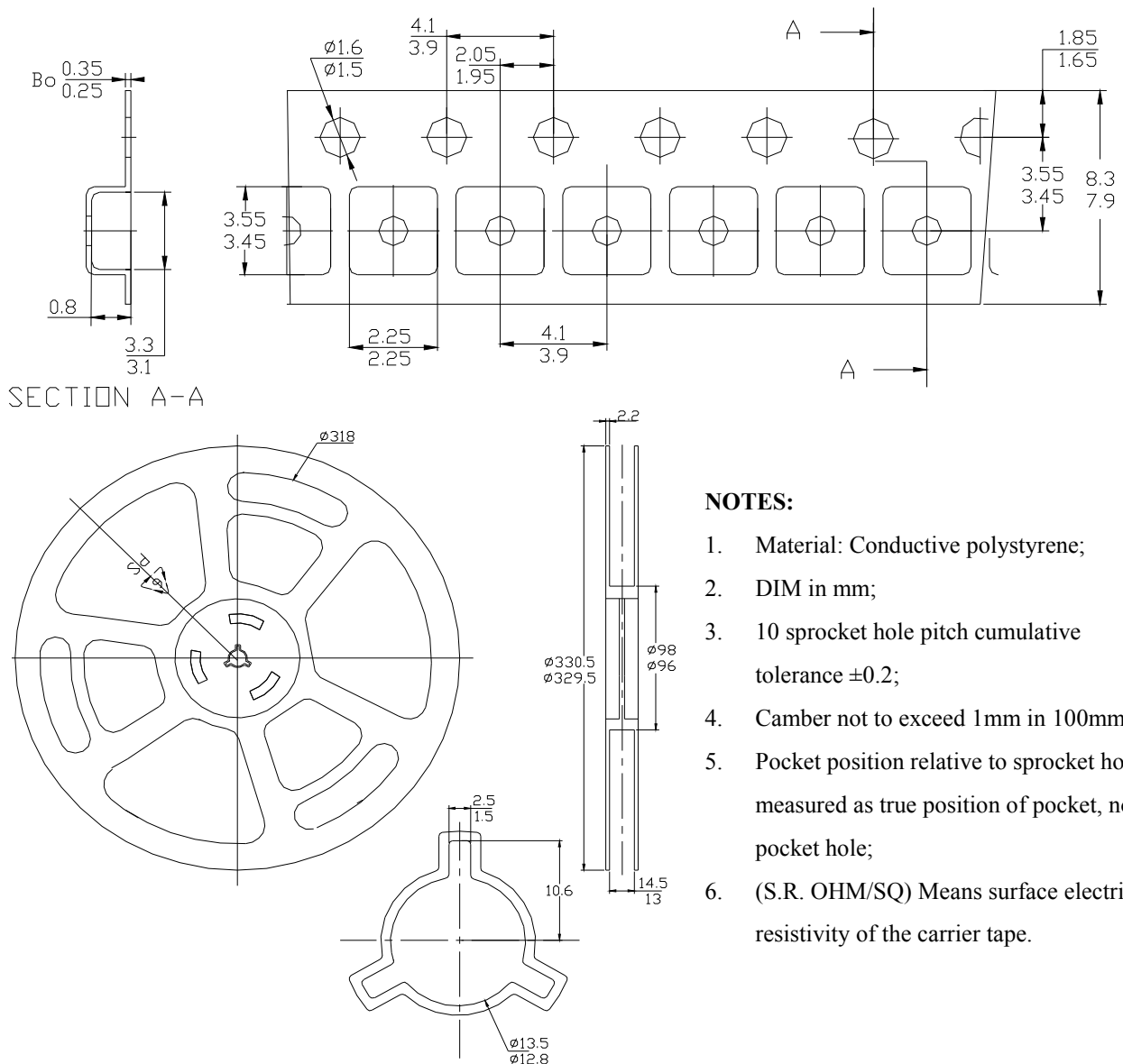
TSot 25 package Tape On Reel Dimension



NOTES:

1. Material: Conductive polystyrene;
2. DIM in mm;
3. 10 sprocket hole pitch cumulative tolerance ± 0.2 ;
4. Camber not to exceed 1mm in 100mm;
5. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole;
6. (S.R. OHM/SQ) Means surface electric resistivity of the carrier tape.

USON package Tape On Reel Dimension



NOTES:

1. Material: Conductive polystyrene;
2. DIM in mm;
3. 10 sprocket hole pitch cumulative tolerance ± 0.2 ;
4. Camber not to exceed 1mm in 100mm;
5. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole;
6. (S.R. OHM/SQ) Means surface electric resistivity of the carrier tape.

MH 248 Labeling on ESD beg in different selection

MH 248ESO/UA/ST/SU

  MSL1 260°C	P/N: MH-248EUA Sorting: Pkg Idf: 01 Lot No.: Date Code: Quantity:	  MSL 1 260°C	P/N: MH-248ESO Sorting: Pkg Idf: 05 Lot No.: Date Code: Quantity:
  MSL 1 260°C	P/N: MH-248EST Sorting: Pkg Idf: 06 Lot No.: Date Code: Quantity:	  MSL 1 260°C	P/N: MH-248ESU Sorting: Pkg Idf: 07 Lot No.: Date Code: Quantity:

MH 248ESO/UA/ST/SU- α

  MSL1 260°C	P/N: MH-248EUA Sorting: α Pkg Idf: 01 Lot No.: Date Code: Quantity:	  MSL 1 260°C	P/N: MH-248ESO Sorting: α Pkg Idf: 05 Lot No.: Date Code: Quantity:
  MSL 1 260°C	P/N: MH-248EST Sorting: α Pkg Idf: 06 Lot No.: Date Code: Quantity:	  MSL 1 260°C	P/N: MH-248ESU Sorting: α Pkg Idf: 07 Lot No.: Date Code: Quantity:

MH 248ESO/UA/ST/SU- β

  MSL1 260°C	P/N: MH-248EUA Sorting: β Pkg Idf: 01 Lot No.: Date Code: Quantity:	  MSL 1 260°C	P/N: MH-248ESO Sorting: β Pkg Idf: 05 Lot No.: Date Code: Quantity:
  MSL 1 260°C	P/N: MH-248EST Sorting: β Pkg Idf: 06 Lot No.: Date Code: Quantity:	  MSL 1 260°C	P/N: MH-248ESU Sorting: β Pkg Idf: 07 Lot No.: Date Code: Quantity:

MH 248ESO/UA/ST/SU-γ

  MSL1 260°C	P/N: MH-248EUA Sorting: γ Pkg Idf: 01 Lot No.: Date Code: Quantity:	  MSL 1 260°C	P/N: MH-248ESO Sorting: γ Pkg Idf: 05 Lot No.: Date Code: Quantity:
  MSL 1 260°C	P/N: MH-248EST Sorting: γ Pkg Idf: 06 Lot No.: Date Code: Quantity:	  MSL 1 260°C	P/N: MH-248ESU Sorting: γ Pkg Idf: 07 Lot No.: Date Code: Quantity: